

<b>Notice of References Cited</b>	Application/Control No. 10/529,995		Applicant(s)/Patent Under Reexamination MAETZ ET AL.	
	Examiner Nnenna N. Ekpo		Art Unit 2623	Page 1 of 1

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*	B	US-2002/0059623	05-2002	Rodriguez et al.	725/91
*	C	US-2004/0236778	11-2004	Junqua et al.	707/100
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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